



## **30V N-Channel MOSFETs**

### **General Description**

These N-Channel enhancement mode power field effect transistors are using SGT MOSFET technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

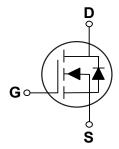
BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	Ι <sub>D</sub>
30 V	0.7 mΩ	250 A

#### **Features**

- $R_{DS(ON)} \le 0.7 m\Omega @V_{GS} = 10V$
- · Fast Switching
- · Green Device Available

### PPAK5X6 Pin Configuration





### **Applications**

- · Boost Driver
- · Brushless Motor
- BLDC

Absolute Maximum Ratings T <sub>c</sub> =25°C unless otherwise noted					
Symbol	Parameter	Value	Units		
V <sub>DS</sub>	Drain-Source Voltage	30	V		
$V_{GS}$	Gate-Source Voltage	±20	V		
I <sub>D</sub>	Drain Current – Continuous (T <sub>C</sub> =25°C)	250	Α		
I <sub>DM</sub>	Drain Current – Pulsed (NOTE 1)	1000	Α		
EAS	Single Pulse Avalanche Energy (NOTE 2)	1332	mJ		
$P_{D}$	Power Dissipation (T <sub>C</sub> =25°C)	165	W		
$T_J$	Operating Junction Temperature Range	-55 to 150	°C		
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C		
Marking Code		NC0P7			

Thermal Characteristics					
Symbol	Parameter	Value	Unit		
$R_{\theta JA}$	Thermal Resistance Junction to Ambient	50	°C/W		
$R_{ heta JC}$	Thermal Resistance Junction to Case	0.75	°C/W		





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### Electrical Characteristics (T<sub>J</sub>=25°C, unless otherwise noted)

#### **Off Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS}$ =0V , $I_D$ =250uA	30	-		V
I <sub>DSS</sub>	Drain-Source Leakage Current	$V_{DS}$ =30V , $V_{GS}$ =0V			1	uA
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS}$ =±20V , $V_{DS}$ =0V			±100	nA

#### On Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V , I <sub>D</sub> =20A			0.7	mΩ
		$V_{GS}$ =4.5V , $I_D$ =10A			1	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}=V_{DS}$ , $I_D=250uA$	1.2		2.5	V

#### **Dynamic and switching Characteristics (NOTE 4)**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$Q_g$	Total Gate Charge			147.4		
$Q_gs$	Gate-Source Charge	$V_{DS}$ =15V , $V_{GS}$ =10V , $I_{D}$ =20A		25.2		nC
$Q_{gd}$	Gate-Drain Charge			18		
$T_{d(on)}$	Turn-On Delay Time	$V_{DD}$ =15V , $V_{GS}$ =10V , $R_{G}$ =3 $\Omega$ , $I_{D}$ =20A		14.8		
T <sub>r</sub>	Rise Time			15.6		nS
$T_{d(off)}$	Turn-Off Delay Time			106		110
$T_f$	Fall Time			49		
$C_{iss}$	Input Capacitance	V <sub>DS</sub> =15V , V <sub>GS</sub> =0V , F=1MHz		9130		
C <sub>oss</sub>	Output Capacitance			3360		pF
$C_{rss}$	Reverse Transfer Capacitance			300		
$R_g$	Gate resistance	$V_{GS}$ =0V , $V_{DS}$ =0V , F=1MHz		1.4		Ω

### **Drain-Source Diode Characteristics and Ratings**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current	V <sub>G</sub> =V <sub>D</sub> =0V, Force Current			250	Α
$V_{SD}$	Diode Forward Voltage (NOTE 3)	V <sub>GS</sub> =0V , I <sub>S</sub> =20A			1.2	V

### NOTES:

- 1. Repetitive Rating: Pulsed width limited by maximum junction temperature.
- 2. The EAS data shows Max. rating. The test condition is  $V_{DD}$ =24V, L=0.5mH,  $V_{GS}$ =10V,  $I_{AS}$ =73A.
- 3. The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%.
- 4. This value is guaranteed by design hence it is not included in the production test.



# P5MNC0P7



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### **Characteristics Curves**

FIG. 1-Transfer Characteristics

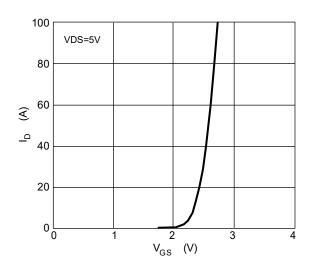


FIG. 2- $I_S$  vs  $V_{SD}$ 

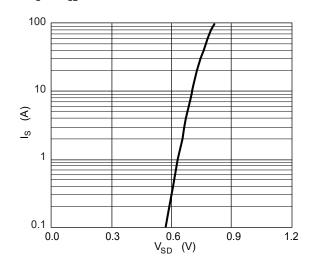


FIG. 3-R $_{\rm DS(on)}$  vs  $\rm I_{\rm D}$ 

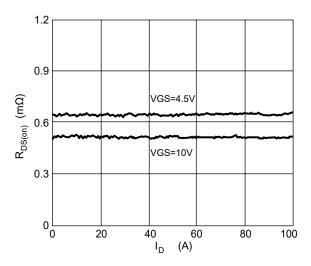


FIG. 4-Normalized R<sub>DS(on)</sub> vs T<sub>J</sub>

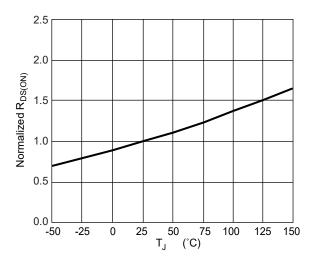


FIG. 5-Gate Charge Characteristics

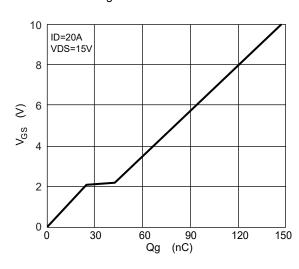
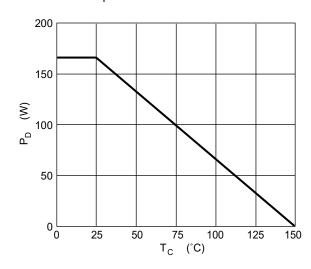


FIG. 6-Power Dissipation





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### **Characteristics Curves**

FIG. 7-Switching Time Waveform

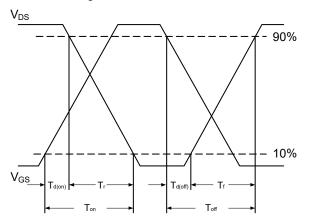
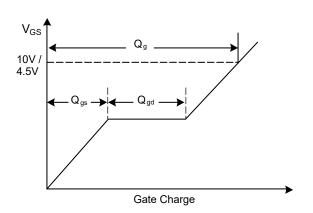
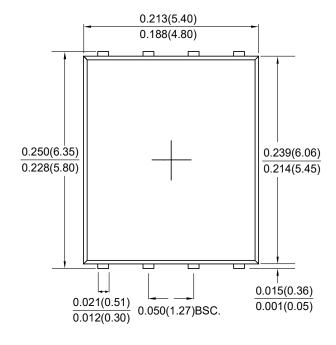
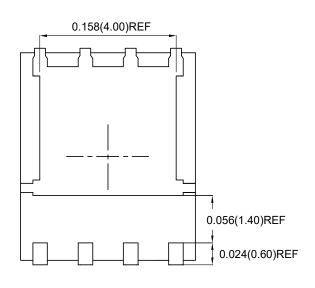


FIG. 8-Gate Charge Waveform



### **Package Outline Dimensions**









### PPAK5X6

Dimensions in inches and (millimeters)





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